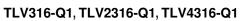




Order





SBOS845B-NOVEMBER 2016-REVISED AUGUST 2017

Support &

Community

20

TLVx316-Q1

Technical

Documents

10-MHz, Rail-to-Rail Input/Output, Low-Voltage, 1.8-V CMOS Operational Amplifiers

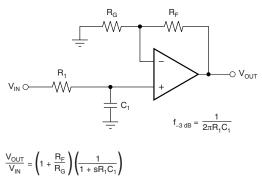
Features 1

- **Qualified for Automotive Applications**
- AEC-Q100 With the Following Results:
 - Device Temperature Grade 1: -40°C to +125°C Ambient Operating Temperature Range
 - **Device HBM ESD Classification Level 3A**
 - Device CDM ESD Classification Level C5 _
- Unity-Gain Bandwidth: 10 MHz
- Low I_{Ω} : 400 μ A/ch
 - Excellent Power-to-Bandwidth Ratio
 - Stable I_Q Over Temperature and Supply Range
- Wide Supply Range: 1.8 V to 5.5 V
- Low Noise: 12 nV/VHz at 1 kHz
- Low Input Bias Current: ±10 pA
- Offset Voltage: ±0.75 mV
- Unity-Gain Stable
- Internal RFI and EMI Filter
 - Number of Channels:
 - TLV316-Q1: 1
 - TLV2316-Q1: 2
 - TLV4316-Q1: 4
- Extended Temperature Range: -40°C to +125°C

2 Applications

- Automotive Applications:
 - ADAS
 - Body Electronics and Lighting
 - Current Sensing
 - Battery Management Systems

Single-Pole, Low-Pass Filter



3 Description

Tools &

Software

The TLV316-Q1 (single), TLV2316-Q1 (dual), and TLV4316-Q1 (quad) devices comprise a family of general-purpose, low-power operational amplifiers. Features such as rail-to-rail input and output swings, low quiescent current (400 µA/ch typical) combined with a wide bandwidth of 10 MHz, and very-low noise (12 nV/ \sqrt{Hz} at 1 kHz) make this family suitable for a circuits requiring a good speed and power ratio. The low input bias current supports operational amplifiers that are used in applications with megaohm source impedances. The low-input bias current of the TLVx316-Q1 yields a very-low current noise to make the family attractive for high impedance sensor interfaces.

The robust design of the TLVx316-Q1 provides easeof-use to the circuit designer: a unity-gain stable, integrated RFI and EMI rejection filter, no phase reversal in overdrive condition, and high electrostatic discharge (ESD) protection (4-kV HBM).

These devices are optimized for low-voltage operation as low as 1.8 V (±0.9 V) and up to 5.5 V (±2.75 V). This latest addition of low-voltage CMOS operational amplifiers to the portfolio, in conjunction with the TLVx313-Q1 and TLVx314-Q1 series, offer a family of bandwidth, noise, and power options to meet the needs of a wide variety of applications.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)			
TLV316-Q1	SOT-23 (5)	1.60 mm × 2.90 mm			
TLV2316-Q1	VSSOP (8)	3.00 mm × 3.00 mm			
TLV4316-Q1	TSSOP (14)	4.40 mm × 5.00 mm			

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Low Supply Current (400 µA/Ch) for 10-MHz Bandwidth

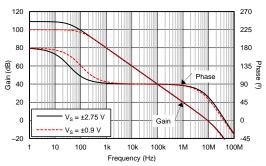




Table of Contents

8.4

9.1

12.1

12.2

12.3 12.4

13

9

1	Feat	lures 1							
2	Арр	Applications 1							
3	Des	cription1							
4	Rev	ision History 2							
5	Dev	ice Comparison Table 3							
6	Pin	Configuration and Functions 4							
7	Spe	cifications7							
	7.1	Absolute Maximum Ratings 7							
	7.2	ESD Ratings7							
	7.3	Recommended Operating Conditions 7							
	7.4	Thermal Information: TLV316-Q1 8							
	7.5	Thermal Information: TLV2316-Q1 8							
	7.6	Thermal Information: TLV4316-Q18							
	7.7	Electrical Characteristics9							
	7.8	Typical Characteristics: Table of Graphs 10							
	7.9	Typical Characteristics 11							
8	Deta	ailed Description 14							
	8.1	Overview 14							
	8.2	Functional Block Diagram 14							

4 Revision History

2

Changes from Revision A (December 2016) to Revision B Corrected typo; changed part numbers from TLV314, TLV2314, and TLV4314 to TLV316-Q1, TLV2316-Q1, and TLV4316-Q1 in Features section 1

Changes from Original (November 2016) to Revision A

•	Changed the CDM ESD Classification Level from C6 to C5 in the Features section	1
•	Deleted the SC70 (5), SOIC (8), and SOIC (14) packages from the Device Information table	1
•	Deleted the DCK (SC70) package from the TLV316-Q1 pinout diagram in the <i>Pin Configurations and Functions</i> section	4
•	Deleted the DCK (SC70) pinout information from the <i>Pin Functions: TLV316-Q1</i> table in the <i>Pin Configurations and Functions</i> section	4
•	Deleted D (SOIC) package from the TLV2316-Q1 pinout diagram in the Pin Configurations and Functions section	5
•	Deleted the D (SOIC) package from TLV4316-Q1 pinout diagram in the Pin Configurations and Functions section	6
•	Changed the ESD Ratings table from commercial to automotive specifications	7
•	Changed the CDM ESD rating from ±1500 to ±750 in the ESD Ratings table	7
•	Deleted the DCK (SC70) package from the Thermal Information: TLV316-Q1 table in the Specifications section	8
•	Changed the formatting of all Thermal Information table notes	8
•	Deleted the D (SOIC) package from the <i>Thermal Information: TLV2316-Q1</i> table in the <i>Specifications</i> section	8
•	Deleted the D (SOIC) package from the <i>Thermal Information: TLV4316-Q1</i> table in the <i>Specifications</i> section	8
•	Deleted the static literature number in the SBOA128 application note reference in the <i>EMI Susceptibility and Input</i> <i>Filtering</i> section	6
•	Deleted the static literature number in document reference in the Layout Guidelines section	9
•	Changed the layout example image (Figure 41) in Layout Example section 1	9
•	Deleted the static literature numbers from document references in <i>Related Documentation</i> section	

Product Folder Links: TLV316-Q1 TLV2316-Q1 TLV4316-Q1

Copyright © 2016-2017, Texas Instruments Incorporated

Page

Page

STRUMENTS

EXAS

8.3 Feature Description...... 15

Application Information..... 17 9.2 System Examples 17 10 Power Supply Recommendations 18 10.1 Input and ESD Protection 18 11.1 Layout Guidelines 19 11.2 Layout Example 19 12 Device and Documentation Support 20

> Documentation Support 20 Related Links 20

Trademarks 20 12.5 Electrostatic Discharge Caution 21

Information 21

Mechanical, Packaging, and Orderable

Device Functional Modes...... 16 Application and Implementation 17



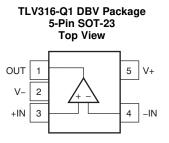
5 Device Comparison Table

DEVICE	NO. OF			PACKAGE-LEADS		
DEVICE	CHANNELS	DBV	DCK	D	DGK	PW
TLV316-Q1	1	5	5	—	—	_
TLV2316-Q1	2	—	—	8	8	—
TLV4316-Q1	4	—	—	14	—	14

TEXAS INSTRUMENTS

www.ti.com

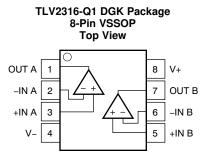
6 Pin Configuration and Functions



Pin Functions: TLV316-Q1

PIN		I/O	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
-IN	4	I	Inverting input	
+IN	3	I	Noninverting input	
OUT	1	0	Output	
V–	2	_	Negative (lowest) supply or ground (for single-supply operation)	
V+	5	—	ositive (highest) supply	





Pin Functions: TLV2316 -Q1

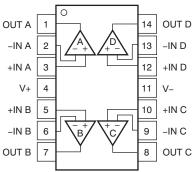
	PIN	I/O	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
–IN A	2	I	Inverting input, channel A	
+IN A	3	I	Noninverting input, channel A	
–IN B	6	I	Inverting input, channel B	
+IN B	5	I	Noninverting input, channel B	
OUT A	1	0	Output, channel A	
OUT B	7	0	Output, channel B	
V-	4	—	legative (lowest) supply or ground (for single-supply operation)	
V+	8	—	Positive (highest) supply	

TLV316-Q1, TLV2316-Q1, TLV4316-Q1 SBOS845B – NOVEMBER 2016 – REVISED AUGUST 2017

TEXAS INSTRUMENTS

www.ti.com

TLV4316-Q1 PW Package 14-Pin TSSOP Top View



Pin Functions: TLV4316-Q1

PIN		1/0	DECODIDITION
NAME	NO.	I/O	DESCRIPTION
–IN A	2	I	Inverting input, channel A
+IN A	3	I	Noninverting input, channel A
–IN B	6	I	Inverting input, channel B
+IN B	5	I	Noninverting input, channel B
–IN C	9	I	Inverting input, channel C
+IN C	10	I	Noninverting input, channel C
–IN D	13	I	Inverting input, channel D
+IN D	12	I	Noninverting input, channel D
OUT A	1	0	Output, channel A
OUT B	7	0	Output, channel B
OUT C	8	0	Output, channel C
OUT D	14	0	Output, channel D
V-	11	—	Negative (lowest) supply or ground (for single-supply operation)
V+	4	—	Positive (highest) supply

6



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature (unless otherwise noted)⁽¹⁾

			MIN	МАХ	UNIT
Supply voltage				7	V
Signal input pins	Voltage ⁽²⁾	Common-mode	(V–) – 0.5	(V+) + 0.5	V
	voltage ⁽⁼⁾	Differential		(V+) - (V-) + 0.2	v
	Current ⁽²⁾		-10	10	mA
Output short-circu	uit ⁽³⁾		Cont	inuous	mA
	Specified, T _A		-40	125	
Temperature	Junction, T _J			150	°C
	Storage, T _{stg}		-65	150	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Input pins are diode-clamped to the power-supply rails. Current limit input signals that can swing more than 0.5 V beyond the supply rails to 10 mA or less.

(3) Short-circuit to ground, one amplifier per package.

7.2 ESD Ratings

			VALUE	UNIT
M	Floatroatatia diagharrag	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾	±4000	M
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per AEC Q100-011	±750	v

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
V_{S}	Supply voltage	1.8	5.5	V
	Specified temperature range	-40	125	°C

TLV316-Q1, TLV2316-Q1, TLV4316-Q1

SBOS845B-NOVEMBER 2016-REVISED AUGUST 2017

STRUMENTS

XAS

7.4 Thermal Information: TLV316-Q1

	THERMAL METRIC ⁽¹⁾	TLV316-Q1 DBV (SOT-23)	UNIT
		5 PINS	-
R _{0JA}	Junction-to-ambient thermal resistance	221.7	°C/W
R _{0JC(top)}	Junction-to-case(top) thermal resistance	144.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	49.7	°C/W
ΨJT	Junction-to-top characterization parameter	26.1	°C/W
ΨJB	Junction-to-board characterization parameter	49.0	°C/W
R _{0JC(bot)}	Junction-to-case(bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

7.5 Thermal Information: TLV2316-Q1

		TLV2316-Q1	
	THERMAL METRIC ⁽¹⁾	DGK (VSSOP)	UNIT
		8 PINS	
$R_{ ext{ heta}JA}$	Junction-to-ambient thermal resistance	186.6	°C/W
R _{0JC(top)}	Junction-to-case(top) thermal resistance	78.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	107.9	°C/W
ΨJT	Junction-to-top characterization parameter	15.5	°C/W
ΨJB	Junction-to-board characterization parameter	106.3	°C/W
R _{0JC(bot)}	Junction-to-case(bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

7.6 Thermal Information: TLV4316-Q1

		TLV4316-Q1	
	THERMAL METRIC ⁽¹⁾	PW (TSSOP)	UNIT
		14 PINS	
R_{\thetaJA}	Junction-to-ambient thermal resistance	117.8	°C/W
R _{0JC(top)}	Junction-to-case(top) thermal resistance	46.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	59.6	°C/W
ΨJT	Junction-to-top characterization parameter	5.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	59	°C/W
R _{0JC(bot)}	Junction-to-case(bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

7.7 Electrical Characteristics

at $T_A = 25^{\circ}C$, $R_L = 10 \text{ k}\Omega$ connected to $V_S / 2$, $V_{CM} = V_S / 2$, and $V_{OUT} = V_S / 2$ (unless otherwise noted); V_S (total supply voltage) = (V+) - (V-) = 1.8 V to 5.5 V

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFFSET	VOLTAGE						
	1	V _S = 5 V		±0.75	±3		
V _{OS}	Input offset voltage	$V_{\rm S} = 5 \text{ V}, \text{ T}_{\rm A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$			±4.5	mV	
dV _{OS} /dT	Drift	$V_{\rm S} = 5 \text{ V}, \text{ T}_{\rm A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$		±2		μV/°C	
PSRR	Power-supply rejection ratio	V _S = 1.8 V - 5.5 V, V _{CM} = (V-)		±30	±175	μV/V	
	Channel separation, dc	At dc		100		dB	
INPUT VO	OLTAGE RANGE						
V _{CM}	Common-mode voltage range	V _S = 5.5 V	(V–) – 0.2		(V+) + 0.2	V	
CMRR		$ \begin{array}{l} V_{S} = 5.5 \ V, (V\!\!-\!) - 0.2 \ V < V_{CM} < (V\!\!+\!) - 1.4 \ V, \\ T_{A} = -40^{\circ} C \ to \ 125^{\circ} C \end{array} $	72	90		JD	
CMRR	Common-mode rejection ratio	$V_{S} = 5.5 \text{ V}, V_{CM} = -0.2 \text{ V} \text{ to } 5.7 \text{ V}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$		75		dB	
INPUT BI	IAS CURRENT						
I _B	Input bias current			±10		pА	
I _{OS}	Input offset current			±10		pА	
NOISE							
En	Input voltage noise (peak-to-peak)	V _S = 5 V, f = 0.1 Hz to 10 Hz		5		μV_{PP}	
e _n	Input voltage noise density	V _S = 5 V, f = 1 kHz		12		nV/√Hz	
i _n	Input current noise density	f = 1 kHz		1.3		fA/√Hz	
INPUT IM	IPEDANCE						
Z _{ID}	Differential			2 2		$10^{16}\Omega \parallel pF$	
Z _{IC}	Common-mode			2 4		$10^{11}\Omega \parallel pF$	
	DOP GAIN	1					
		$V_{S} = 5.5 \text{ V}, (V-) + 0.05 \text{ V} < V_{O} < (V+) - 0.05 \text{ V}, $ 100 104					
A _{OL}	Open-loop voltage gain	$\label{eq:V_S} \begin{array}{ l l l l l l l l l l l l l l l l l l l$	104			dB	
FREQUE	NCY RESPONSE						
GBP	Gain bandwidth product	V _S = 5 V, G = 1		10		MHz	
φ _m	Phase margin	V _S = 5 V, G = 1		60		Degrees	
SR	Slew rate	V _S = 5 V, G = 1		6		V/µs	
ts	Settling time	To 0.1%, V _S = 5 V, 2-V step , G = 1, C _L = 100 pF		1		μS	
t _{OR}	Overload recovery time	$V_{S} = 5 V, V_{IN} \times gain = V_{S}$		0.8		μS	
THD + N	Total harmonic distortion + noise $^{(1)}$	$V_{S} = 5 V, V_{O} = 0.5 V_{RMS}, G = 1, f = 1 \text{ kHz}$		0.008%			
OUTPUT							
V	Voltage output swing from supply	V_{S} = 1.8 V to 5.5 V, R_{L} = 10 $k\Omega$			35	m\/	
Vo	rails	$V_{\rm S}$ = 1.8 to 5.5 V, $R_{\rm L}$ = 2 k Ω			125	mV	
I _{SC}	Short-circuit current	V _S = 5 V		±50		mA	
Zo	Open-loop output impedance	V _S = 5 V, f = 10 MHz		250		Ω	
POWER S	SUPPLY						
Vs	Specified voltage range		1.8		5.5	V	
IQ	Quiescent current per amplifier	$V_{S} = 5 \text{ V}, I_{O} = 0 \text{ mA}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$		400	575	μA	
TEMPER	ATURE				ļ		
T _A	Specified		-40		125	°C	
			1				

(1) Third-order filter; bandwidth = 80 kHz at - 3 dB.



7.8 Typical Characteristics: Table of Graphs

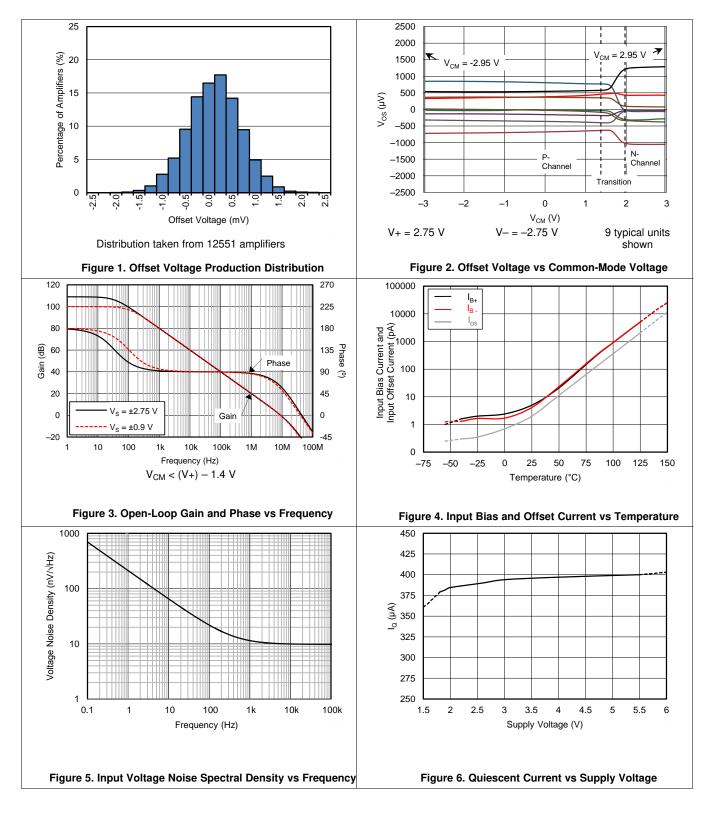
Table 1. Table of Graphs

TITLE	FIGURE
Offset Voltage Production Distribution	Figure 1
Offset Voltage vs Common-Mode Voltage	Figure 2
Open- Loop Gain and Phase vs Frequency	Figure 3
Input Bias and Offset Current vs Temperature	Figure 4
Input Voltage Noise Spectral Density vs Frequency	Figure 5
Quiescent Current vs Supply Voltage	Figure 6
Small-Signal Overshoot vs Load Capacitance	Figure 7
No Phase Reversal	Figure 8
Small-Signal Step Response	Figure 9
Large-Signal Step Response	Figure 10
Short-Circuit Current vs Temperature	Figure 11
Electromagnetic Interference Rejection Ratio Referred to Noninverting Input vs Frequency	Figure 12
Channel Separation vs Frequency	Figure 13



7.9 Typical Characteristics

at $T_A = 25^{\circ}$ C, $V_S = 5.5$ V, $R_L = 10$ k Ω connected to V_S / 2, $V_{CM} = V_S$ / 2, and $V_{OUT} = V_S$ / 2, (unless otherwise noted)

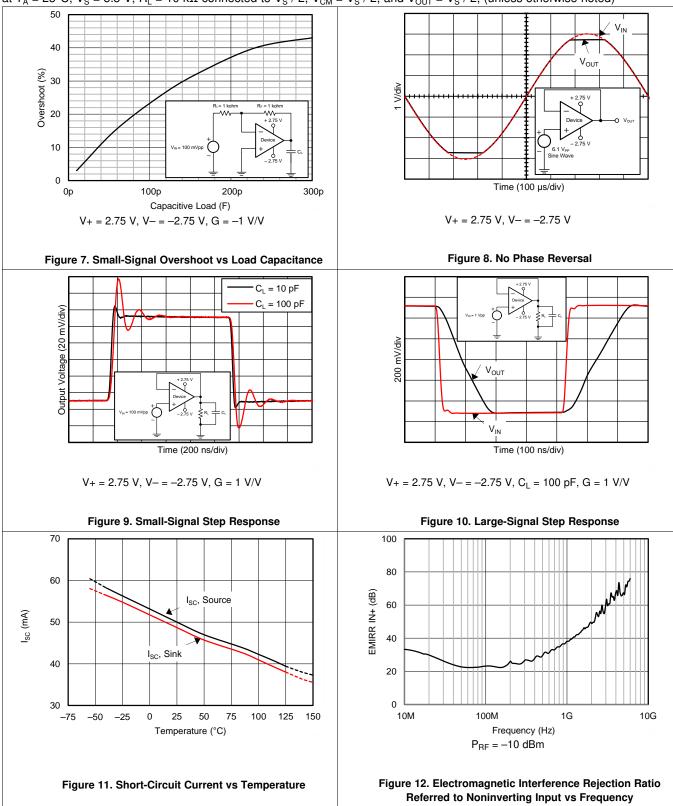


TLV316-Q1, TLV2316-Q1, TLV4316-Q1

SBOS845B-NOVEMBER 2016-REVISED AUGUST 2017



at $T_A = 25^{\circ}C$, $V_S = 5.5 \text{ V}$, $R_L = 10 \text{ k}\Omega$ connected to $V_S / 2$, $V_{CM} = V_S / 2$, and $V_{OUT} = V_S / 2$, (unless otherwise noted)



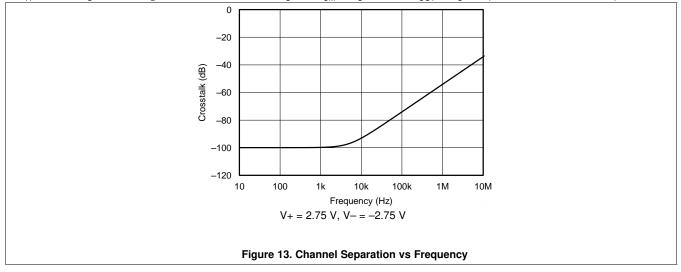


www.ti.com



Typical Characteristics (continued)

at $T_A = 25^{\circ}$ C, $V_S = 5.5$ V, $R_L = 10$ k Ω connected to $V_S / 2$, $V_{CM} = V_S / 2$, and $V_{OUT} = V_S / 2$, (unless otherwise noted)



Texas Instruments

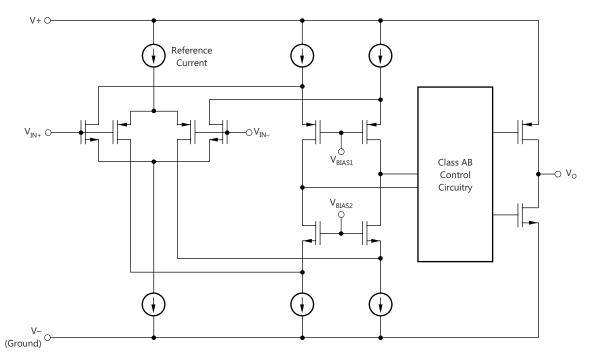
8 Detailed Description

8.1 Overview

The TLVx316-Q1 is a family of low-power, rail-to-rail input and output operational amplifiers. These devices operate from 1.8 V to 5.5 V, are unity-gain stable, and are suitable for a wide range of general-purpose applications. The class AB output stage is capable of driving ≤ 10 -k Ω loads connected to any point between V+ and ground. The input common-mode voltage range includes both rails and allows the TLVx316-Q1 to be used in virtually any single-supply application. Rail-to-rail input and output swing significantly increases dynamic range, especially in low-supply applications, and makes them suitable for driving sampling analog-to-digital converters (ADCs).

The TLVx316-Q1 features 10-MHz bandwidth and 6-V/ μ s slew rate with only 400- μ A supply current per channel, providing good ac performance at very-low-power consumption. DC applications are well served with a very-low input noise voltage of 12 nV/ \sqrt{Hz} at 1 kHz, low input bias current (5 pA), and an input offset voltage of 0.5 mV (typical).

8.2 Functional Block Diagram



Copyright © 2017, Texas Instruments Incorporated



8.3 Feature Description

8.3.1 Operating Voltage

The TLVx316-Q1 operational amplifiers are fully specified and ensured for operation from 1.8 V to 5.5 V. In addition, many specifications apply from -40° C to $+125^{\circ}$ C. Parameters that vary significantly with operating voltages or temperature are illustrated in the *Typical Characteristics* section.

8.3.2 Rail-to-Rail Input

The input common-mode voltage range of the TLVx316-Q1 extends 200 mV beyond the supply rails for supply voltages greater than 2.5 V. This performance is achieved with a complementary input stage: an N-channel input differential pair in parallel with a P-channel differential pair, as shown in the *Functional Block Diagram*. The N-channel pair is active for input voltages close to the positive rail, typically (V+) - 1.4 V to 200 mV above the positive supply, whereas the P-channel pair is active for inputs from 200 mV below the negative supply to approximately (V+) - 1.4 V. There is a small transition region, typically (V+) - 1.2 V to (V+) - 1 V, in which both pairs are on. This 200-mV transition region can vary up to 200 mV with process variation. Thus, the transition region (both stages on) can range from (V+) - 1.4 V to (V+) - 1.2 V on the low end, up to (V+) - 1 V to (V+) - 0.8 V on the high end. Within this transition region, PSRR, CMRR, offset voltage, offset drift, and THD can be degraded compared to device operation outside this region.

8.3.3 Rail-to-Rail Output

Designed as a low-power, low-voltage operational amplifier, the TLVx316-Q1 delivers a robust output drive capability. A class AB output stage with common-source transistors is used to achieve full rail-to-rail output swing capability. For resistive loads of 10 k Ω , the output swings typically to within 30 mV of either supply rail regardless of the power-supply voltage applied. Different load conditions change the ability of the amplifier to swing close to the rails; see .

8.3.4 Common-Mode Rejection Ratio (CMRR)

CMRR for the TLVx316-Q1 is specified in two ways so the best match for a given application can be selected. The *Electrical Characteristics* table provides the CMRR of the device in the common-mode range below the transition region [$V_{CM} < (V_+) - 1.4 V$]. This specification is the best indicator of device capability when the application requires using one of the differential input pairs. The CMRR over the entire common-mode range is specified at $V_{CM} = -0.2 V$ to 5.7 V for $V_S = 5.5 V$. This last value includes the variations through the transition region.

8.3.5 Capacitive Load and Stability

The TLVx316-Q1 is designed for applications where driving a capacitive load is required. As with all operational amplifiers, there may be specific instances where the TLVx316-Q1 can become unstable. The particular operational amplifier circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether or not an amplifier is stable in operation. An operational amplifier in the unity-gain (1 V/V) buffer configuration that drives a capacitive load exhibits a greater tendency to be unstable than an amplifier operated at a higher noise gain. The capacitive load, in conjunction with the operational amplifier output resistance, creates a pole within the feedback loop that degrades the phase margin. The degradation of the phase margin increases when the capacitive loading increases. For a conservative best practice, designing for 25% overshoot (40° phase margin) provides improved stability over process variations. The equivalent series resistance (ESR) of some very-large capacitors (C_L capacitors with a value greater than 1 μ F) is sufficient to alter the phase characteristics in the feedback loop such that the amplifier remains stable. Increasing the amplifier closed-loop gain allows the amplifier to drive increasingly larger capacitance. This increased capability is evident when observing the overshoot response of the amplifier at higher voltage gains, as shown in Figure 7 (G = -1 V/V).

TLV316-Q1, TLV2316-Q1, TLV4316-Q1 SBOS845B – NOVEMBER 2016 – REVISED AUGUST 2017

TEXAS INSTRUMENTS

www.ti.com

Feature Description (continued)

One technique for increasing the capacitive load drive capability of the amplifier operating in a unity-gain configuration is to insert a small resistor (typically $10 \cdot \Omega$ to $20 \cdot \Omega$) in series with the output, as shown in Figure 14. This resistor significantly reduces the overshoot and ringing associated with large capacitive loads. One possible problem with this technique, however, is that a voltage divider is created with the added series resistor and any resistor connected in parallel with the capacitive load. The voltage divider introduces a gain error at the output that reduces the output swing.

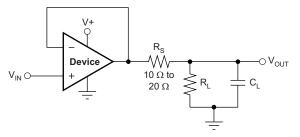


Figure 14. Improving Capacitive Load Drive

8.3.6 EMI Susceptibility and Input Filtering

Operational amplifiers vary with regard to the susceptibility of the device to electromagnetic interference (EMI). If conducted EMI enters the operational amplifier, the dc offset measured at the amplifier output can shift from the nominal value when EMI is present. This shift is a result of signal rectification associated with the internal semiconductor junctions. Although EMI can affect all operational amplifier pin functions, the signal input pins are likely to be the most susceptible. The TLVx316-Q1 operational amplifier family incorporates an internal input low-pass filter that reduces the amplifier response to EMI. This filter provides both common-mode and differential-mode filtering. The filter is designed for a cutoff frequency of approximately 80 MHz (–3 dB), with a roll-off of 20 dB per decade.

The immunity of an operational amplifier can be accurately measured and quantified over a broad frequency spectrum extending from 10 MHz to 6 GHz. The EMI rejection ratio (EMIRR) metric allows operational amplifiers to be directly compared by the EMI immunity. Figure 12 illustrates the results of this testing on the TLVx316-Q1. Detailed information can be found in *EMI Rejection Ratio of Operational Amplifiers*, available for download from www.ti.com.

8.3.7 Overload Recovery

Overload recovery is defined as the time required for the operational amplifier output to recover from a saturated state to a linear state. The output devices of the operational amplifier enter a saturation region when the output voltage exceeds the rated operating voltage, either because of the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices require time to return back to the linear state. After the charge carriers return back to the linear state, the device begins to slew at the specified slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time. The overload recovery time for the TLVx316-Q1 is approximately 300 ns.

8.4 Device Functional Modes

The TLVx316-Q1 family has a single functional mode. These devices are powered on as long as the power-supply voltage is between 1.8 V (\pm 0.9 V) and 5.5 V (\pm 2.75 V).



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TLV316-Q1, TLV2316-Q1, and TLV4316-Q1 devices are powered on when the supply is connected. The devices can operate as a single-supply operational amplifier or a dual-supply amplifier, depending on the application.

9.2 System Examples

When receiving low-level signals, the device often requires limiting the bandwidth of the incoming signals into the system. The simplest way to establish this limited bandwidth is to place an RC filter at the noninverting pin of the amplifier, as shown in Figure 15.

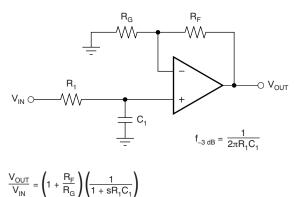


Figure 15. Single-Pole, Low-Pass Filter

If even more attenuation is needed, the device requires a multiple-pole filter. The Sallen-Key filter can be used for this task, as shown in Figure 16. For best results, the amplifier must have a bandwidth that is eight to ten times the filter frequency bandwidth. Failure to follow this guideline can result in a phase shift of the amplifier.

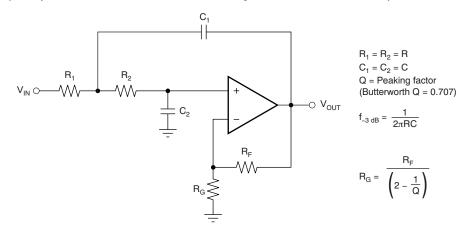


Figure 16. Two-Pole, Low-Pass, Sallen-Key Filter



10 Power Supply Recommendations

The TLVx316-Q1 family is specified for operation from 1.8 V to 5.5 V (\pm 0.9 V to \pm 2.75 V); many specifications apply from –40°C to +125°C. The *Typical Characteristics* section presents parameters that can exhibit significant variance with regard to operating voltage or temperature.

CAUTION

Supply voltages larger than 7 V can permanently damage the device; see the *Absolute Maximum Ratings* table.

Place $0.1-\mu F$ bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or highimpedance power supplies. For more detailed information on bypass capacitor placement, see the *Layout Guidelines* section.

10.1 Input and ESD Protection

The TLVx316-Q1 incorporates internal ESD protection circuits on all pins. For input and output pins, this protection primarily consists of current-steering diodes connected between the input and power-supply pins. These ESD protection diodes provide in-circuit, input overdrive protection, as long as the current is limited to 10 mA, as stated in the *Absolute Maximum Ratings* table. Figure 17 shows how a series input resistor can be added to the driven input to limit the input current. The added resistor contributes thermal noise at the amplifier input and the value must be kept to a minimum in noise-sensitive applications.

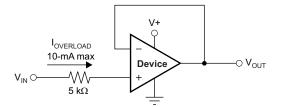


Figure 17. Input Current Protection

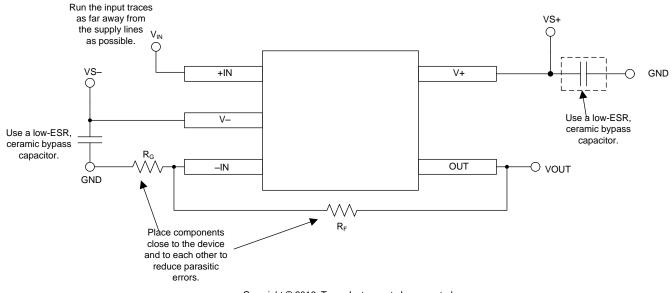


11 Layout

11.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the
 operational amplifier. Bypass capacitors reduce the coupled noise by providing low-impedance power
 sources local to the analog circuitry.
 - Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- Separate grounding for analog and digital portions of the circuitry is one of the simplest and most
 effective methods of noise suppression. One or more layers on multilayer PCBs are typically devoted to
 ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Take care to
 physically separate digital and analog grounds, paying attention to the flow of the ground current. For
 more detailed information, see *Circuit Board Layout Techniques*.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicularly is much better than crossing in parallel with the noisy trace.
- Place the external components as close to the device as possible. Keeping R_F and R_G close to the inverting input minimizes parasitic capacitance, as shown in Figure 18.
- Keep the length of input traces as short as possible. Remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.



11.2 Layout Example

Copyright © 2016, Texas Instruments Incorporated

Figure 18. Operational Amplifier Board Layout for a Noninverting Configuration

TEXAS INSTRUMENTS

www.ti.com

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

TLVx313 Low-Power, Rail-to-Rail In/Out, 500-µV Typical Offset, 1-MHz Operational Amplifier for Cost-Sensitive Systems

TLVx314 3-MHz, Low-Power, Internal EMI Filter, RRIO, Operational Amplifier

EMI Rejection Ratio of Operational Amplifiers

QFN/SON PCB Attachment

Quad Flatpack No-Lead Logic Packages

Circuit Board Layout Techniques

Single-Ended Input to Differential Output Conversion Circuit Reference Design

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TLV316-Q1	Click here	Click here	Click here	Click here	Click here
TLV2316-Q1	Click here	Click here	Click here	Click here	Click here
TLV4316-Q1	Click here	Click here	Click here	Click here	Click here

Table 2. Related Links

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E[™] Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

Copyright © 2016–2017, Texas Instruments Incorporated



12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	Package	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
TLV2316QDGKRQ1	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	16M6	Samples
TLV2316QDGKTQ1	ACTIVE	VSSOP	DGK	8	250	RoHS & Green	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	16M6	Samples
TLV316QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	16ND	Samples
TLV316QDBVTQ1	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	16ND	Samples
TLV4316QPWRQ1	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	V4316Q1	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



10-Dec-2020

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TLV2316-Q1, TLV316-Q1, TLV4316-Q1 :

• Catalog: TLV2316, TLV316, TLV4316

NOTE: Qualified Version Definitions:

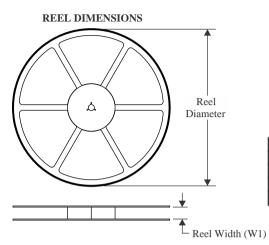
• Catalog - TI's standard catalog product

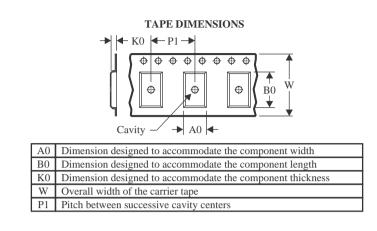


Texas

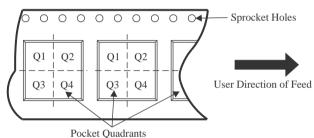
STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

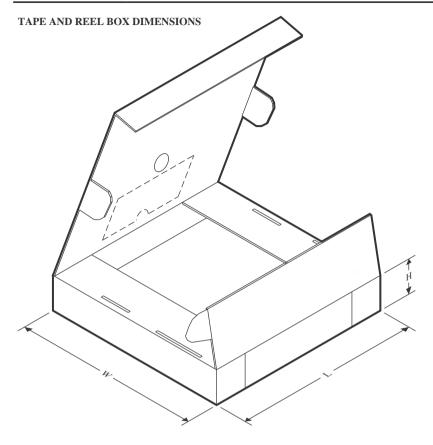


*All dimensions are nominal												t.
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV2316QDGKRQ1	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TLV2316QDGKTQ1	VSSOP	DGK	8	250	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TLV316QDBVRQ1	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
TLV316QDBVTQ1	SOT-23	DBV	5	250	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
TLV4316QPWRQ1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLV2316QDGKRQ1	VSSOP	DGK	8	2500	366.0	364.0	50.0
TLV2316QDGKTQ1	VSSOP	DGK	8	250	366.0	364.0	50.0
TLV316QDBVRQ1	SOT-23	DBV	5	3000	180.0	180.0	18.0
TLV316QDBVTQ1	SOT-23	DBV	5	250	180.0	180.0	18.0
TLV4316QPWRQ1	TSSOP	PW	14	2000	356.0	356.0	35.0

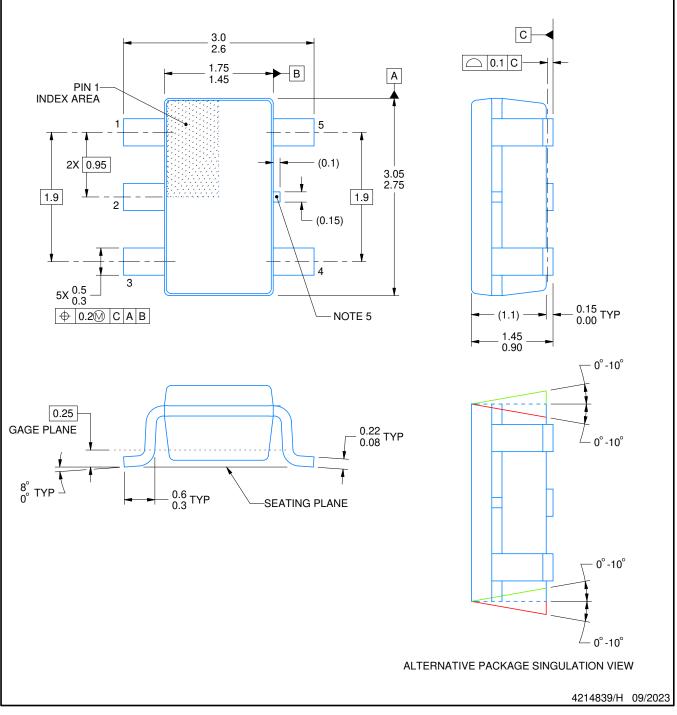
DBV0005A



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.This drawing is subject to change without notice.Refernce JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



DBV0005A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

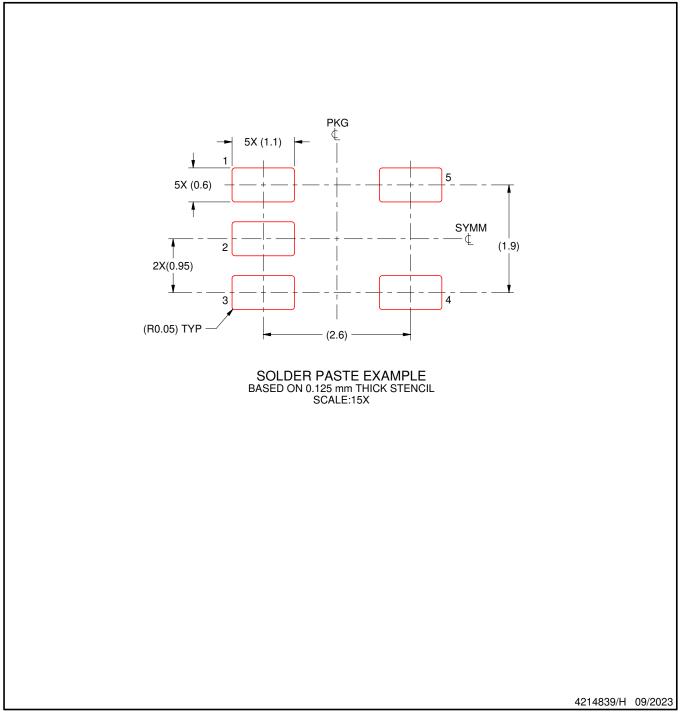


DBV0005A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the international difference of the international difference

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.

- D> Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



DGK (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2023, Texas Instruments Incorporated